## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10542260	AN, CHI-YUP
Examiner	Art Unit
Gail Verbitsky	2855

SEARCHED						
Class		Subclass	Date	Examiner		
374	147		11/18/08	gv		

SEARCH NOTES			
Search Notes	Date	Examiner	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	
-				

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